


Search Notes 	Application/Control No. 10590850	Applicant(s)/Patent Under Reexamination FUJISAWA ET AL.
	Examiner Cho, Jennifer Y	Art Unit 1621

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STIC Search	11/19/07	LH
East Search	11/19/07	JC
Inventor Search	11/19/07	JC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner